Search Notes

Applicant(s)/Patent under Reexamination

10/693,146

CHEN, KWANG-TSAN

Examiner

3746

Emmanuel Sayoc

SEARCHED					
Class	Subclass	Date	Examiner		
417	415	10/13/05	63		
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[37	538	10/14/01	68		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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